

ONT-503/506/512 In A Nutshell

Testing Design, Conformance, and Integration of Next Generation Transport Networks

ONT-5xx platform strengths

Multi-Application

Capable of supporting standard SONET/SDH/DSn/PDH BERT testing as well as OTN, Jitter/Wander, NextGen SONET (GFP, VCat, LCAS), DWDM Optical Spectrum Analysis, and Ethernet. No other vendor provides this range of technologies in a single platform.

Multi-User

User ID and password-based system allows multiple users (various groups) to access test cards simultaneously and independently.

Multi-Port

3, 6 or 12 slots available in "Screen and Handle" or rack mount form factors. Cards are swappable between mainframes and mainframes can be daisy-chained to provide a seamless interface to all modules.

- Utilizes the Linux operating system for superior networking and security.
- Measurement results of all ports have a common time base.
- Parallel remote GUI and remote command line access eases test script development.
- Browser and TCP/IP technology support international testing groups.
- Highly developed Tcl libraries and C respectively LW CVI drivers speed development of automated test scripts.

Multi-Application Multi-User Multi-Port Multi-Channel

> SONET SDH DSn/PDH NewGen Ethernet OTN Jitter Wander Remote TCP/IP LWdriver Tcl/Tk





Multi-channel testing strengths

- Allows parallel processing of full 2.5G bandwidth with mixed mappings down to the VT1.5/VC-11 level.
- Works in conjunction with any ONT optical interface card at OC-3/12/48/192 and STM-1/4/16/64.
- Industry-leading service disruption measurement on all channels simultaneously, with user-defined pass/ fail threshold and event separation time with full frame resolution.
- Unique event list, with time stamps, shows all errors, alarms and service disruptions of all channels that can be sorted with multiple criteria.
- Detailed error and alarm insertion (single, rate, burst, rate burst) on user-selectable paths.
- Overhead manipulation supported at • section, line and path layers. Two-byte overhead capture allows K1/K2 logging.
- Auto-configure Rx detects all mappings, payloads, and traces at the press of a button.
- Through mode on path level allows monitoring of signal details plus alarm and error insertion.
- Automated connectivity check quickly identifies changes in cross-connected paths.

NextGen SONET/SDH testing strengths

- Supports full LCAS emulation on 10Gb/s and 2.5 Gb/s interfaces with both highorder and low-order virtual concatenation.
- LCAS state tracer records all message changes of the LCAS protocol to verify correct implementation.
- Supports differential delay insertion and analysis on each individual VCG member. An automatic stress test verifies the maximum delay tolerance of the DUT for each delay combination.

- Supported payloads include **Ethernet** via framed GFP and PRBS in a D+K pattern to mimic fibre channel signals via transparent GFP.
- NextGen SONET/SDH and Ethernet • interfaces running in parallel on one mainframe allow interworking testing including lost packet count, singledirection latency measurements, and asymmetrical traffic generation.
- Automatic scanner supports easy channel structure detection and configuration setting for high number low order groups.
- Ethernet interfaces featuring a comprehensive set of dynamic error and alarm insertion capabilities on the physical and MAC Layer.

OTN testing strengths

- Supports testing at 10.7G and 2.7G according to ITU-T G.709 with SONET, SDH, and bulk PRBS payloads.
- · Detailed insertion and analysis of FEC errors including correctable, uncorrectable, and user-definable errors. One-button FEC stress test provides 100% FEC algorithm verification in less than two seconds.
- Full **OTN overhead support** including frame alignment signal, SM and PM trail trace identifier, and backward defect indicator.
- Full tandem connection monitoring support for TCM1 to TCM6 including trail trace identifiers, BIP, BEI, and BDI indications.
- Wrapper/De-wrapper mode allows verification of client integrity through OTN mappers and FEC encoders.
- Full featured **OSA with drop** enables the simultaneous testing of the DWDM optical layer and OTN/FEC layer, and provides access to FEC channels at the regeneration interface.

Jitter/Wander testing strengths

- Supports jitter/wander testing at both electrical and optical interfaces for 155M up to 10.7G.
- Jitter receiver accuracy of 15 mUI is the highest accuracy available on the market.
- Fully compliant with the ITU **0.172 Appendix VII** and **Appendix VIII.**
- Single-ended differential input/output converter allows integrated jitter testing of XFP/SFP modules.
- Specialized filter for testing OTN wrapping/de-wrapping iitter allows accurate measurements of large amplitude low-frequency jitter caused by "stuffing" of client into 10.7G carrier.
- Wander measurements up to 1000 samples/s allow testing of phase transients as required by ITU-T G.812.

